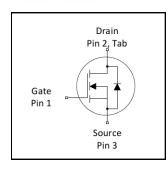
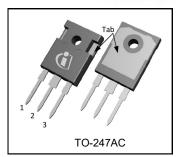
IRFP90N20DPbF



V _{(BR)DSS}	200V
R _{DS(on)} max.	0.023Ω
I _D	94A©





Application

• High frequency DC-DC converters

Benefits

- Low Gate-to-Drain Charge to Reduce Switching Losses
- Fully Characterized Capacitance Including Effective C_{OSS} to Simplify Design
- Fully Characterized Avalanche Voltage and Current
- Lead-Free

Base part number	Package Type	Standard Pack		Orderable Part Number
Base part number	i dekage Type	Form	Quantity	Orderable Fait Namber
IRFP90N20DPbF	TO-247AC	Tube	25	IRFP90N20DPbF

Symbol	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V	94⑥	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V	66	Α
I _{DM}	Pulsed Drain Current ①	380	
P _D @T _C = 25°C	Maximum Power Dissipation	580	W
	Linear Derating Factor	3.8	W/°C
V_{GS}	Gate-to-Source Voltage	± 30	V
E _{AS}	Single Pulse Avalanche Energy ②	1010	mJ
I _{AR} Avalanche Current ①		56	Α
E _{AR}	Repetitive Avalanche Energy ①	58	mJ
dv/dt	Peak Diode Recovery dv/dt③	6.7	V/ns
T_J	Operating Junction and	-55 to + 175	
T _{STG}	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	
	Mounting torque, 6-32 or M3 screw	10 lbf•in (1.1N•m)	

Thermal Resistance

Symbol	Parameter	Тур.	Max.	Units
$R_{ heta JC}$	Junction-to-Case		0.26	
$R_{ heta CS}$	Case-to-Sink, Flat, Greased Surface	0.24		°C/W
$R_{ heta JA}$	Junction-to-Ambient		40	

IRFP90N20DPbF



Static @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	200			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient		0.24		V/°C	Reference to 25°C, I _D = 1mA
R _{DS(on)}	Static Drain-to-Source On-Resistance			0.023	Ω	V _{GS} = 10V, I _D = 56A ④
$V_{GS(th)}$	Gate Threshold Voltage	3.0		5.0	V	$V_{DS} = V_{GS}$, $I_D = 250\mu A$
gfs	Forward Trans conductance	39			S	$V_{DS} = 50V, I_{D} = 56A$
I	Drain-to-Source Leakage Current			25		$V_{DS} = 200V, V_{GS} = 0V$
IDSS	Diali-to-Source Leakage Current			250	μΛ	$V_{DS} = 160V, V_{GS} = 0V, T_{J} = 150^{\circ}C$
1	Gate-to-Source Forward Leakage			100	2	$V_{GS} = 30V$
IGSS	Gate-to-Source Reverse Leakage			-100	nA	$V_{GS} = -30V$

Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

=			-	-	
Q_g	Total Gate Charge	 180	270		I _D = 56A
Q_{gs}	Gate-to-Source Charge	 45	67	nC	V _{DS} = 160V
Q_{gd}	Gate-to-Drain Charge	 87	130		V _{GS} = 10V ④
$t_{d(on)}$	Turn-On Delay Time	 23			$V_{DD} = 100V$
t _r	Rise Time	 160			I _D = 56A
$t_{d(off)}$	Turn-Off Delay Time	 43		ns	R_G = 1.2 Ω
t _f	Fall Time	 79			V _{GS} = 10V ④
C_{iss}	Input Capacitance	 6040			$V_{GS} = 0V$
C_{oss}	Output Capacitance	 1070			$V_{DS} = 25V$
C_{rss}	Reverse Transfer Capacitance	 170		_	f = 1.0MHz
C_{oss}	Output Capacitance	 8350		pF	$V_{GS} = 0V, V_{DS} = 1.0V, f = 1.0MHz$
C _{oss}	Output Capacitance	 420			$V_{GS} = 0V, V_{DS} = 160V, f = 1.0MHz$
Coss. eff.	Effective Output Capacitance	 870			$V_{GS} = 0V, V_{DS} = 0V \text{ to } 160V$

Diode Characteristics

	Parameter	Min.	Тур.	Max.	Units	Conditions	
Is	Continuous Source Current (Body Diode)			94⑥	_	MOSFET symbol showing the	
I _{SM}	Pulsed Source Current (Body Diode) ①			380		integral reverse p-n junction diode.	
V_{SD}	Diode Forward Voltage			1.5	V	$T_J = 25^{\circ}C, I_S = 56A, V_{GS} = 0V $ ④	
t _{rr}	Reverse Recovery Time		230	340	ns	$T_J = 25^{\circ}C$, $I_F = 56A$	
Q _{rr}	Reverse Recovery Charge		1.9	2.8	μC	di/dt = 100A/μs ④	

Notes:

- $\ensuremath{\mathbb{O}}$ Repetitive rating; pulse width limited by max. junction temperature.
- $\label{eq:local_local_local} \text{\Im} \quad I_{SD} \leq 56A, \; di/dt \leq 470A/\mu s, \; V_{DD} \leq V_{(BR)DSS}, \; T_J \leq 175^{\circ}C.$
- 4 Pulse width $\leq 300 \mu s$; duty cycle $\leq 2\%$.
- \odot C_{oss} eff. is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}
- © Calculated continuous current based on maximum allowable junction temperature. Package limitation current is 90A.



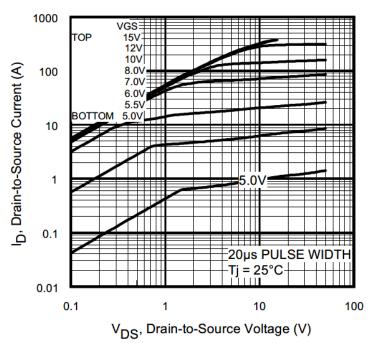


Fig. 1 Typical Output Characteristics

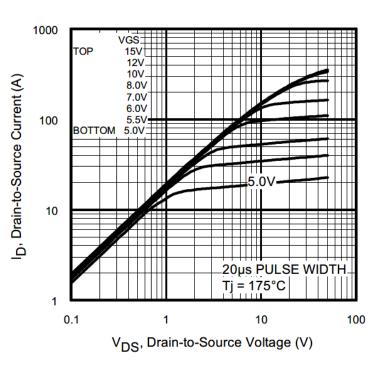


Fig. 2 Typical Output Characteristics

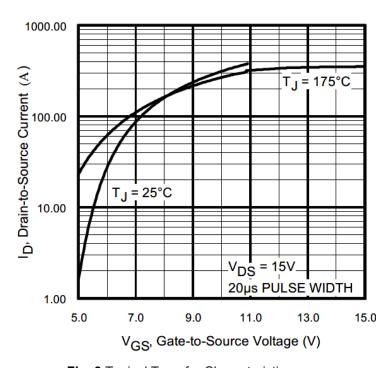


Fig. 3 Typical Transfer Characteristics

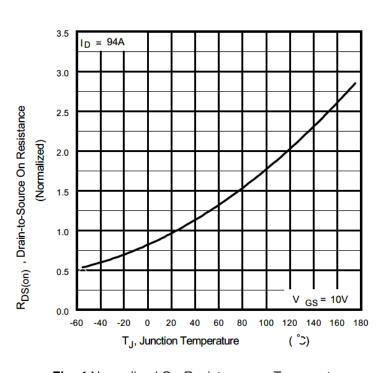


Fig. 4 Normalized On-Resistance vs. Temperature



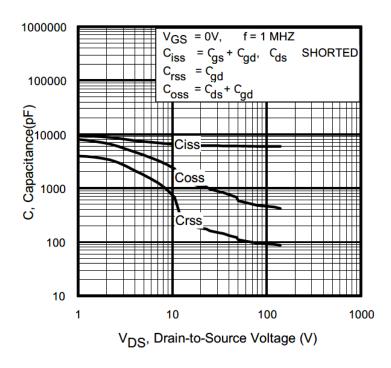


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

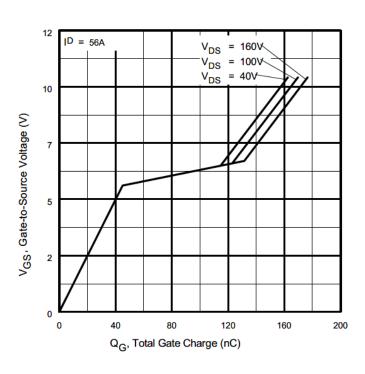


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage

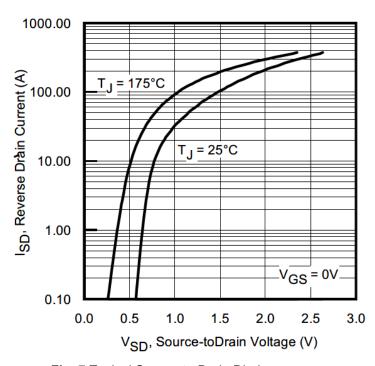


Fig. 7 Typical Source-to-Drain Diode Forward Voltage

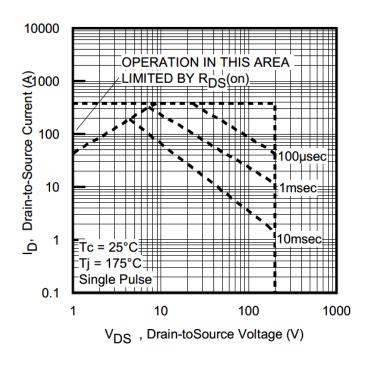


Fig 8. Maximum Safe Operating Area



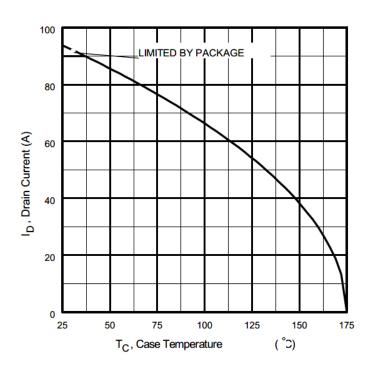


Fig 9. Maximum Drain Current vs. Case Temperature

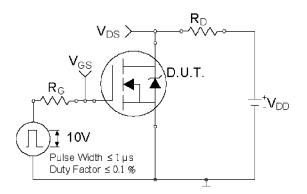


Fig 10a. Switching Time Test Circuit

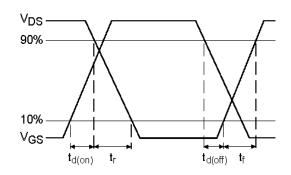


Fig 10a. Switching Time Waveforms

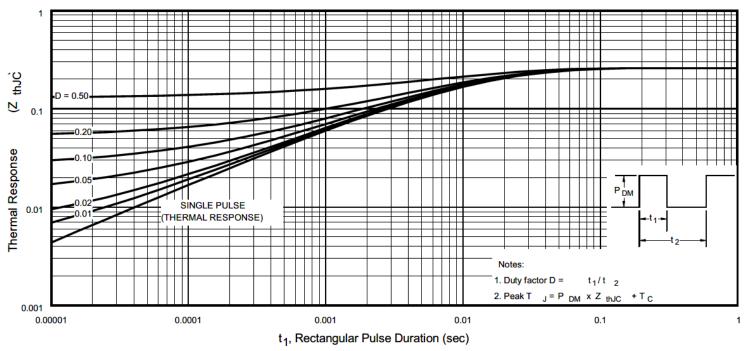


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case



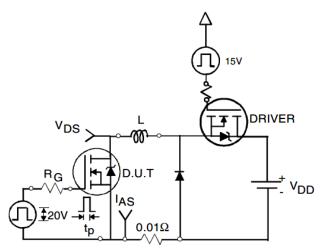


Fig. 12a. Unclamped Inductive Test Circuit

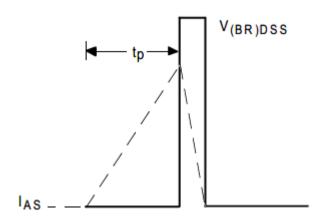


Fig. 12b. Unclamped Inductive Waveforms

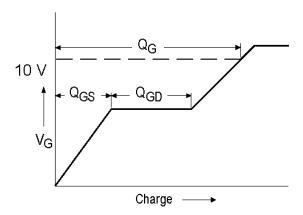


Fig 13a. Basic Gate Charge Waveform

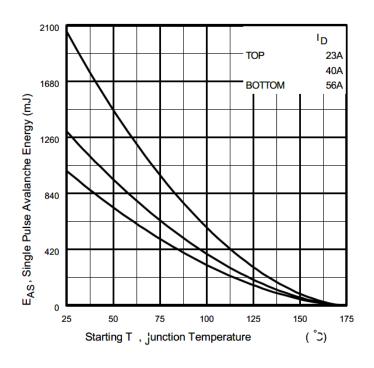


Fig 12c. Maximum Avalanche Energy vs. Drain Current

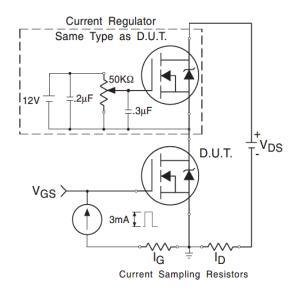
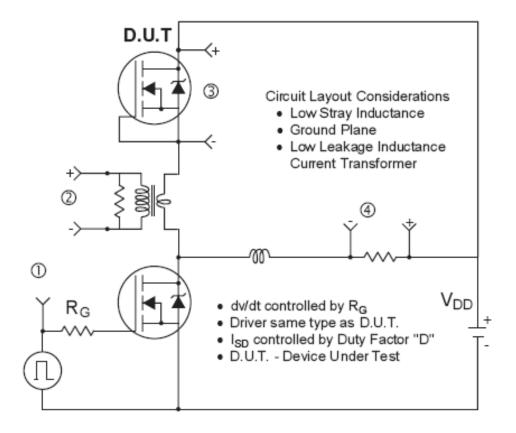
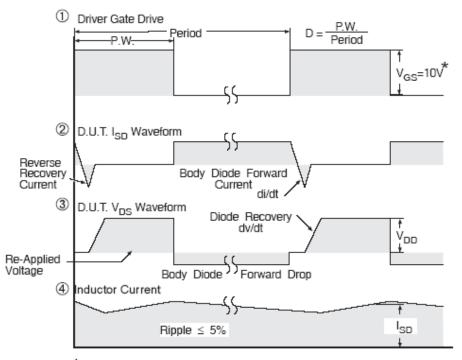


Fig 13b. Gate Charge Test Circuit





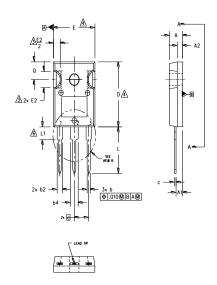


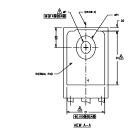
* V_{GS} = 5V for Logic Level Devices

Fig 14. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

infineon

TO-247AC Package Outline (Dimensions are









NOTES:

1. DIMENSIONING AND TOLERANCING AS PER ASME Y14.5M 1994.

2. DIMENSIONS ARE SHOWN IN INCHES.

<u>_3</u>.

CONTOUR OF SLOT OPTIONAL.

DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005" (0.127)
PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.

<u>5</u>.

THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS D1 & E1.

LEAD FINISH UNCONTROLLED IN L1.

 $\mbox{\it MP}$ to have a maximum draft angle of 1.5 $^{\circ}$ to the top of the part with a maximum hole diameter of .154 inch.

8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-247AC .

DIMENSIONS						
SYMBOL	INC	HES	MILLIM	ETERS		
	MIN.	MAX.	MIN.	MAX.	NOTES	
A	.183	.209	4.65	5.31		
A1	.087	.102	2.21	2.59		
A2	.059	.098	1.50	2.49		
b	.039	.055	0.99	1.40		
ь1	.039	.053	0.99	1.35		
b2	.065	.094	1.65	2.39		
b3	.065	.092	1.65	2.34		
b4	.102	.135	2.59	3.43		
b5	.102	.133	2.59	3.38		
С	.015	.035	0.38	0.89		
c1	.015	.033	.033 0.38			
D	.776	.815 19.71		20.70	4	
D1	.515	-	13.08	-	5	
D2	.020	.053	0.51	1.35		
E	.602	.625	15.29	15.87	4	
E1	.530	-	13.46	-		
E2	.178	.216	4.52	5.49		
e	.215	BSC	5.46	BSC		
Øk	.0	10	0.	25		
L	.559	.634	14.20	16.10		
L1	.146	.169	3.71	4.29		
øΡ	.140	.144	3.56	3.66		
øP1	-	.291	-	7.39		
Q	.209	.224	5.31	5.69		
S	.217	BSC	5.51	5.51 BSC		
L	l		ll			

LEAD ASSIGNMENTS

<u>HEXFET</u>

- 1.- GATE
- 2.- DRAIN 3.- SOURCE
- 4.- DRAIN

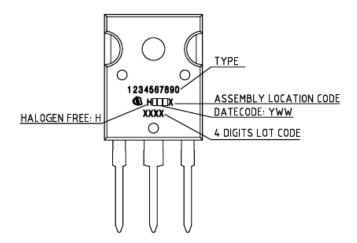
IGBTs, CoPACK

- 1.- GATE
- 2.- COLLECTOR 3.- EMITTER
- 4.- COLLECTOR

DIODES

- 1.- ANODE/OPEN
- 2.- CATHODE
- 3.- ANODE

TO-247AC Part Marking Information



TO-247AC package is not recommended for Surface Mount Application.

IRFP90N20DPbF



Revision History

Date	Rev.	Comments
2024-10-03	2.1	 Update datasheet to Infineon format Updated Part marking –page 8
		Added disclaimer on last page.

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